

Notice of References Cited

Application/Control No.

10/585,692

Applicant(s)/Patent Under

Reexamination

TAKAHASHI, YORIO

Examiner

MARK CONNOLY

Art Unit

2115

Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2006/0200693	09-2006	Uehara, Keiichi	713/324
*	B US-2005/0289567	12-2005	Sun et al.	720/610
*	C US-2003/0219134	11-2003	Su et al.	381/104
*	D US-7,457,975	11-2008	Taniguchi et al.	713/324
*	E US-7,099,113	08-2006	Lee et al.	360/133
*	F US-6,654,827	11-2003	Zhang et al.	710/62
*	G US-6,611,658	08-2003	Takahashi, Yorio	388/800
*	H US-6,006,285	12-1999	Jacobs et al.	710/14
*	I US-5,944,832	08-1999	Jolley et al.	713/300
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 06259876 A	09-1994	Japan	HIGUCHI, KOZABURO	
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.